IN THE CLAIMS:

1. (currently amended) A crystalline material characterized in that it does not contain fluorides, with a composition in a roasted state corresponding to that of the material called ITQ-17 and in that it has a composition on an anhydrous base and in terms of moles of oxides upon being synthesized, unroasted, represented by: xX₂O₃: (1-z)YO₂: zGeO₂: r/n R_nO wherein:

X is at least one trivalent element,

Y is one or more tetravalent elements other than germanium,

R is an organic structure directing compound,

x varies between 0 and 0.02, preferably between 0 and 0.01,

z is comprised between 0.02 and 0.67, preferably between 0.04 and 0.5,

r varies between 0.01 and 0.5, preferably between 0.01 and 0.25, and

n is 1 or 2,

and whose most representative values of the X-ray diffraction angle are the following:

2θ +/- 0.5 (degrees)	Intensity (I/Io)
6.89	w, m
9.57	vs
19.35	m
21.37	m
21.90	vs

vs: very strong, m: medium, w: weak.

2. (currently amended) A crystalline material according to claim 1, whose composition on an anhydrous base and in terms of moles of oxide upon being synthesized, unroasted, may be represented by:

$$xX_2O_3$$
: tTO_2 : $(1-z-t)SiO_2$: $zGeO_2$: $r/n R_nO$ wherein:

T is one or more tetravalent elements other than Ge or Si,
t varies between 0 and 0.15, preferably between 0 and 0.10, and
z is comprised between 0.02 and 0.67, preferably between 0.04 and 0.5, and "x", "X",
"R", "r" and "n" have the meaning given in claim 1.

- 3. (previously presented) A crystalline material according to claim 1 or 2, wherein R is the cation 1-methyl-4-aza, 1-azoniumbicyclo [2.2.2] octane (DABMe⁺).
- 4. (previously presented) A crystalline material according to claim 1 or 2, wherein R is the cation 1,4-bis[N-(4-aza, 1-azoniumbicyclo [2,2,2] octane) methyl]benzene (d-DABBz)²⁺.
- 5. (currently amended) A crystalline material according to claim 1 wherein Y is one or more tetravalent elements selected among from the group consisting of Si, Sn, Ti and V and mixtures thereof.
- 6. (previously presented) A crystalline material according to claim 1 wherein Y is Si.
- 7. (currently amended) A crystalline material according to claim 1 or 2, wherein X is one or more trivalent elements element selected from the group consisting of B, Al, In, Ga, Fe and Cr.
- 8. (currently amended) A crystalline material according to claim 2, wherein T is one or more tetravalent elements selected between from the group consisting of V, Sn, and Ti and mixtures thereof.

9. (currently amended) A crystalline material according to claim 2, whose composition expressed in molar ratios is the following:

ROH/(SiO₂+GeO₂+TO₂) is between 0.5 and 0.01, preferably between 0.25 and 0.01 GeO₂/(SiO₂+GeO₂+TO₂) is between 0.67 and 0.02, preferably between 0.5 and 0.04 (SiO₂+GeO₂+TO₂)/X₂O₃ is between ∞ and 50, preferably between .infin. and 100 and TO₂/(SiO₂+GeO₂+TO₂) is between 0.15 and 0, preferably between 0.1 and 0.

10. (currently amended) A crystalline material according to claim 2, whose composition expressed in molar ratios is the following:

 $R(OH)_2/(SiO_2+GeO_2+TO_2)$: between 0.25 and 0.005, preferably between 0.125 and 0.005

GeO2/(SiO₂+GeO₂+TO₂): between 0.67 and 0.02, preferably between 0.5 and 0.04 (SiO₂+GeO₂+TO₂)/X₂O₃: between ∞ and 50, preferably between ∞ and 100 TO₂/(SiO₂+GeO₂+TO₂): between 0.15 and 0, preferably between 0.1 and 0.

11. (currently amended) A process for synthesizing a crystalline material that does not contain fluorides, with a composition in a roasted state corresponding to that of the material called ITQ-17 and in that it has a composition on an anhydrous base and in terms of moles of oxides upon being synthesized, unroasted, represented by:

 xX_2O_3 : (1-z)YO₂: zGeO₂: r/n R_nO wherein:

X is at least one trivalent element,

Y is one or more tetravalent elements other than germanium,

R is an organic structure directing compound,

x varies between 0 and 0.02, preferably between 0 and 0.01,

z is comprised between 0.02 and 0.67, preferably between 0.04 and 0.5,

r varies between 0.01 and 0.5, preferably between 0.01 and 0.25, and

n is 1 or 2,

and whose most representative values of the X-ray diffraction angle are the following:

2θ +/- 0.5 (degrees)	Intensity (I/Io)
6.89	w, m
9.57	VS
19.35	m
21.37	m
21.90	vs

vs: very strong, m: medium, w: weak,

and whose process comprises:

a) preparing a synthesis mixture that comprises at least:

a source of one or several tetravalent elements included under the name Y, a source of Ge,

a source of at least one structure directing agent, and water;

- b) keeping the synthesis mixture at temperatures between 100 and 200° C, until the crystalline material is formed, and
- c) recovering the crystalline material.
- 12. (previously presented) A process according to claim 11, wherein the source of germanium and of the rest of the tetravalent elements is an oxide.
- 13. (currently amended) A process according to claim 11, wherein the synthesis mixture also comprises a source selected among from the group consisting of:
 - a source of one or more trivalent elements, X, a source of one or more tetravalent elements other than Si and Ge, and
 - a mixture of both mixtures thereof.

14. (currently amended) A process according to claim 11, wherein the source of the structure directing agent, R, is 1-methyl-4-aza, 1-azoniumbicyclo [2,2,2] octane hydroxide (DABMeOH), and wherein the synthesis mixture has a composition expressed in terms of molar ratios in the following intervals:

 $H_2O/(YO_2+GeO_2)$: between 100 and 0.01, preferably between 50 and 0.1, OH'/(YO_2+GeO_2): between 3 and 0.01, preferably between 1 and 0.03, R/(YO_2+GeO_2): between 3 and 0.01, preferably between 1 and 0.03, GeO_2/(YO_2+GeO_2): between 0.67 and 0.02, preferably between 0.5 and 0.04, and $(YO_2+GeO_2)/X_2O_3$: between ∞ and SO_3 , preferably between SO_3 and SO_4 , and SO_4 and SO_5 , preferably between SO_5 and SO_6 .

15. (currently amended) A process according to claim 11, wherein the source of the structure directing agent, R, is 1,4-bis[N-(4-aza, 1-azoniumbicyclo [2,2,2] octane) methyl]benzene hydroxide (d-DABBz(OH)₂), and wherein the synthesis mixture has a composition expressed in terms of molar ratios in the following intervals:

 $H_2O/(YO_2+GeO_2)$: between 100 and 0.01, preferably between 50 and 0.1, OH.sup.-YO₂+GeO₂): between 3 and 0.01, preferably between 1 and 0.03, R/(YO₂+GeO₂): between 1.5 and 0.005, preferably between 0.5 and 0.015, GeO₂/YO₂+GeO₂-): between 0.657 and 0.02, preferably between 0.5 and 0.04, (YO₂+GeO₂)/X₂O₃: between ∞ and 50, preferably between ∞ and 100.

16. (currently amended) A process according to claim 11, for preparing a material whose composition may be represented by the formula:

 $xX_2O_3\text{: }tTO_2\text{: }(1\text{-}z\text{-}t)SiO_2\text{: }zGeO_2\text{: }r/n\ R_nO$ wherein:

T is one or more tetravalent elements other than Ge or Si,

t varies between 0 and 0.15, preferably between 0 and 0.10,

z is comprised between 0.02 and 0.67, preferably between 0.04 and 0.5, and "x", "X",

"R", "r" and "n" have the meaning given in claim 1, that comprises:

a) preparing a synthesis mixture that comprises at least: a source of silicon, a source of Ge, and a source of at least one structure directing agent (R) and water

- b) keeping the synthesis mixture at temperatures between 100 and 200° C, until the crystalline material is formed, and
 - c) recovering the crystalline material.
- 17. (currently amended) A process according to claim 16, wherein the source of the structure directing agent (R) is 1-methyl-4-aza, 1-azoniumbicyclo [2,2,2] octane hydroxide (DABMeOH), and wherein the synthesis mixture has a composition expressed in terms of molar ratios in the following intervals:

 $H_2O/(SiO_2+GeO_2+TO_2)$: between 100 and 0.01, preferably between 50 and 0.1, OH $/(SiO_2+GeO_2+TO_2)$: between 3 and 0.01, preferably between 1 and 0.03, $R/(SiO_2+GeO_2+TO_2)$: between 3 and 0.01, preferably between 1 and 0.03, $GeO_2/(SiO_2+GeO_2+TO_2)$: between 0.67 and 0.02, preferably between 0.5 and 0.04, $GeO_2/(SiO_2+GeO_2+TO_2)$: between $GeO_2/(SiO_2+GeO_2+TO_2)$ between $GeO_2/(SiO_2+GeO_2+TO_2)$ between $GeO_2/(SiO_2+GeO_2+TO_2)$ between $GeO_2/(SiO_2+GeO_2+TO_2)$ between 0.15 and 0, preferably between 0.1 and 0.

18. (currently amended) A process according to claim 16, wherein the structure directing agent, R, is 1,4-bis[N-(4-aza, 1-azoniumbicyclo [2,2,2] octane) methyl]benzene hydroxide (d-DABBz(OH)₂), and wherein the synthesis mixture has a composition expressed in terms of molar ratios in the following intervals:

 $H_2O/(SiO_2+GeO_2+TO_2)$: between 100 and 0.01, preferably between 50 and 0.1 OH $/(SiO_2+GeO_2+TO_2)$: between 3 and 0.01, preferably between 1 and 0.03 $R/(SiO_2+GeO_2+TO_2)$: between 1.5 and 0.005, preferably between 0.5 and 0.015 $GeO_2/(SiO_2+GeO_2+TO_2)$: between 0.67 and 0.02, preferably between 0.5 and 0.04 $(SiO_2+GeO_2+TO_2)/X_2O_3$: between ∞ and 50, preferably between ∞ and 100, $TO_2/(SiO_2+GeO_2+TO_2)$: between 0.15 and 0, preferably between 0.1 and 0.

19. (currently amended) A process according to claim 16, wherein the synthesis mixture comprises one or more tetravalent elements, T, selected among from the group consisting of V, Sn, and Ti, and mixtures thereof.

- 20. (previously presented) A process according to claim 16, wherein the source of germanium, silicon and the rest of the tetravalent elements is an oxide.
- 21. (previously presented) A process according to claim 16, wherein the synthesis mixture also comprises a source of one or more trivalent elements, X.
- 22. (currently amended) A process according to claim 11 or 16 that also comprises a step of post-synthesis treatment of the material, whereby the organic component is removed from the structure by means of a technique selected among-from the group consisting of extraction, roasting and both.
- 23. (currently amended) A material obtained according to the process of claim 22, characterized in that its diffraction diagram has the following as the most important lines:

2θ +/- 0.5 (degrees)	Intensity (I/Io)
6.89	w, m
9.59	vs
21.27	m
21.87	m
27.87	vs <u>.</u>

- 24. (new) A crystalline material according to claim 1 wherein x varies between 0 and 0.01.
- 25. (new) A crystalline material according to claim 1 wherein z is comprised between 0.04 and 0.5.
- 26. (new) A crystalline material according to claim 1 wherein r varies between 0.01 and 0.25.
- 27. (new) A crystalline material according to claim 1 wherein x varies between 0 and 0.01, z is comprised between 0.04 and 0.5, and r varies between 0.01 and 0.25.

- 28. (new) A crystalline material according to claim 2 wherein t varies between 0 and 0.10.
- 29. (new) A crystalline material according to claim 2 wherein z is comprised between 0.04 and 0.5.
- 30. (new) A crystalline material according to claim 2 wherein t varies between 0 and 0.10, and z is comprised between 0.04 and 0.5.
- 31. (new) A process for synthesizing a crystalline material that does not contain fluorides according to claim 11 wherein x varies between 0 and 0.01.
- 32. (new) A process for synthesizing a crystalline material that does not contain fluorides according to claim 11 wherein z is comprised between 0.04 and 0.5.
- 33. (new) A process for synthesizing a crystalline material that does not contain fluorides according to claim 11 r varies between 0.01 and 0.25.
- 34. (new) A process for synthesizing a crystalline material that does not contain fluorides according to claim 11 wherein x varies between 0 and 0.01, z is comprised between 0.04 and 0.5, and r varies between 0.01 and 0.25.